

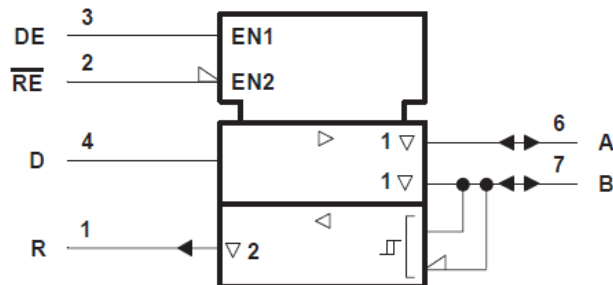
## SNx5ALS176、SN75ALS176A 和 SN75ALS176B 差分总线收发器

### 1 特性

- 符合或超出 TIA/EIA-422-B、TIA/EIA-485-A 的要求<sup>1</sup> 以及 ITU 建议 V.11 和 X.27
- 在高达 35Mbaud 的数据速率下运行
- 提供四个偏差限制：
  - SN65ALS176：15ns
  - SN75ALS176：10ns
  - SN75ALS176A：7.5ns
  - SN75ALS176B：5ns
- 适用于嘈杂环境中长距离总线线路上的多点传输
- 低电源电流要求：30mA（最大值）
- 宽正负输入/输出总线电压范围
- 热关断保护
- 驱动器正负电流限制
- 接收器输入迟滞
- 无干扰上电和断电保护
- 接收器开路失效防护设计

### 2 说明

SN65ALS176 和 SN75ALS176 系列差分总线收发器旨在实现多点总线传输线路上的双向数据通信。这些器件专为平衡传输线路而设计，符合 TIA/EIA-422-B、TIA/EIA-485-A 和 ITU 建议 V.11 和 X.27。



A. 此符号符合 ANSI/IEEE 标准 91-1984 和 IEC 出版物 617-12。

逻辑符号

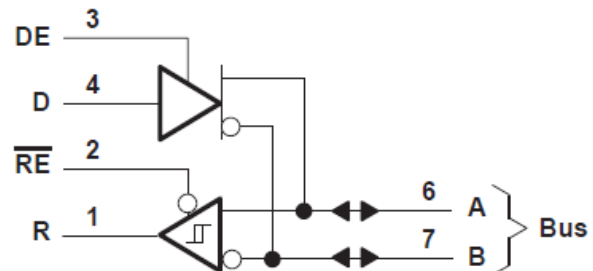
SN65ALS176 和 SN75ALS176 系列整合了一个三态差分线路驱动器和一个差分输入线路接收器，两者均采用 5V 单电源供电。驱动器和接收器分别具有高电平有效和低电平有效使能端，它们可以在外部连接在一起以用作方向控制。驱动器差分输出端和接收器差分输入端在内部连接以形成差分输入/输出 (I/O) 总线端口，这些端口用于在禁用驱动器或  $V_{CC} = 0$  时为总线提供最小负载。该端口具有较宽的正负共模电压范围，使得该器件适用于合用线应用。

SN65ALS176 的额定工作温度范围为  $-40^{\circ}\text{C}$  至  $85^{\circ}\text{C}$ 。SN75ALS176 系列的额定工作温度范围为  $0^{\circ}\text{C}$  至  $70^{\circ}\text{C}$ 。

### 封装信息

器件型号	封装 <sup>(1)</sup>	封装尺寸 (标称值)
SNx5ALS176	D (SOIC)	4.9 mm x 3.91 mm
	P (PDIP)	9.81mm x 6.35mm
SN75ALS176A	D (SOIC)	4.9 mm x 3.91 mm
	P (PDIP)	9.81mm x 6.35mm
SN75ALS176B	D (SOIC)	4.9 mm x 3.91 mm
	P (PDIP)	9.81mm x 6.35mm

(1) 如需了解所有可用封装，请参阅数据表末尾的可订购产品附录。



逻辑图 (正逻辑)

<sup>1</sup> 这些器件符合或超出 TIA/EIA-485-A 的要求，但发生器争用测试（第 3.4.2 段）和发生器电流限制（第 3.4.3 段）除外。对于 SN75ALS176、SN75ALS176A 和 SN75ALS176B，所施加的测试电压范围为  $-6\text{V}$  至  $8\text{V}$ ；对于 SN65ALS180，所施加的测试电压范围为  $-4\text{V}$  至  $8\text{V}$ 。

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### 3 修订历史记录

注：以前版本的页码可能与当前版本的页码不同

<b>Changes from Revision H (June 2000) to Revision I (January 2023)</b>	<b>Page</b>
• 将文档更改为了最新 TI 格式.....	1
• Deleted the Package thermal impedance from the <i>Absolute Maximum Ratings</i> .....	4
• Added the <i>Thermal Information</i> table.....	4
• Changed the <i>Typical Characteristics</i> graphs.....	9

## 4 Pin Configuration and Functions

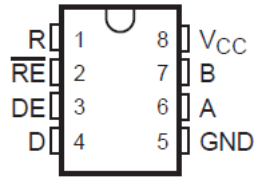


图 4-1. D or P Package (Top View)

表 4-1. Pin Functions

NO	Name	Type	Description
1	R	O	Receive data output
2	$\overline{RE}$	I	Receiver enable, active low
3	DE	i	Driver enable, active high
4	D	I	Driver data input
5	GND	GND	Local device ground
6	A	I/O	Driver output or receiver input (complementary to B)
7	B	I/O	Driver output or receiver input (complementary to A)
8	V <sub>CC</sub>	SUPPLY	4.75-V to 5.25-V supply

## 5 Specifications

### 5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

		MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage <sup>(2)</sup>		7	V
	Voltage range at any bus terminal	-7	12	V
V <sub>I</sub>	Enable input voltage		5.5	V
	Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds		260	°C
T <sub>stg</sub>	Storage temperature range	-65	150	°C

- (1) Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) All voltage values, except differential I/O bus voltage, are with respect to network ground terminal.

### 5.2 建议运行条件

(除非另有说明)

			最小值	标称值	最大值	单位
V <sub>CC</sub>	电源电压		4.75	5	5.25	V
V <sub>I</sub> 或 V <sub>IC</sub>	任何总线端子上的输入电压 (独立或共模)				12	V
					-7	
V <sub>IH</sub>	高电平输入电压	D、DE 和 RE	2			V
V <sub>IL</sub>	低电平输入电压	D、DE 和 RE			0.8	V
V <sub>ID</sub>	差分输入电压 <sup>(1)</sup>				±12	V
I <sub>OH</sub>	高电平输出电流	驱动器			-60	mA
		接收器			-400	
I <sub>OL</sub>	低电平输出电流	驱动器			60	mA
		接收器			8	
T <sub>A</sub>	自然通风工作温度范围	SN65ALS176	-40		85	°C
		SN75ALS176 系列	0		70	

- (1) 差分输入/输出总线电压在同相端子 A 和反相端子 B 之间测得。

### 5.3 Thermal Information

THERMAL METRIC <sup>(1)</sup>		P (PDIP)	D (SOIC) SN65 Devices	D (SOIC) SN75 Devices	UNIT
		8-Pins	8-Pins	8-Pin	
R <sub>θJA</sub>	Junction-to-ambient thermal resistance	65.7	116.7	110	°C/W
R <sub>θJC(top)</sub>	Junction-to-case thermal resistance	54.7	56.3	44.1	°C/W
R <sub>θJB</sub>	Junction-to-board thermal resistance	42.1	63.4	53.5	°C/W
ψ <sub>JT</sub>	Junction-to-top characterization parameter	23	8.8	4.8	°C/W
ψ <sub>JB</sub>	Junction-to-board characterization parameter	41.7	62.6	52.7	°C/W
R <sub>θJC(bot)</sub>	Junction-to-case (bottom) thermal resistance	N/A	N/A	N/A	°C/W

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC package thermal metrics](#) application report.

## 5.4 Electrical Characteristics - Driver

over recommended ranges of supply voltage and operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS <sup>(1)</sup>		MIN	TYP <sup>(2)</sup>	MAX	UNIT
V <sub>IK</sub>	Input clamp voltage	I <sub>I</sub> = -18 mA				-1.5	V
V <sub>O</sub>	Output voltage	I <sub>O</sub> = 0		0		6	V
V <sub>OD1</sub>	Differential output voltage	I <sub>O</sub> = 0		1.5		6	V
V <sub>OD2</sub>	Differential output voltage	R <sub>L</sub> = 100 Ω	See <a href="#">图 6-1</a>	½ V <sub>OD1</sub> or 2 <sup>(3)</sup>			V
		R <sub>L</sub> = 54 Ω	See <a href="#">图 6-1</a>	1.5	2.5	5	V
V <sub>OD3</sub>	Differential output voltage	V <sub>test</sub> = -7 V to 12 V,	See <a href="#">图 6-2</a>	1.5		5	V
Δ V <sub>OD</sub>	Change in magnitude of differential output voltage <sup>(4)</sup>	R <sub>L</sub> = 54 Ω or 100 Ω	See <a href="#">图 6-1</a>			±0.2	V
V <sub>Oc</sub>	Common-mode output voltage	R <sub>L</sub> = 54 Ω or 100 Ω	See <a href="#">图 6-1</a>			3 -1	V
Δ V <sub>Oc</sub>	Change in magnitude of common-mode output voltage <sup>(4)</sup>	R <sub>L</sub> = 54 Ω or 100 Ω	See <a href="#">图 6-1</a>			±0.2	V
I <sub>O</sub>	Output current	Outputs disabled <sup>(6)</sup>		V <sub>O</sub> = 12 V		1	mA
				V <sub>O</sub> = -7 V		-0.8	
I <sub>IH</sub>	High-level input current	V <sub>I</sub> = 2.4 V				20	μA
I <sub>IL</sub>	Low-level input current	V <sub>I</sub> = 0.4 V				-400	μA
I <sub>OS</sub>	Short-circuit output current <sup>(5)</sup>	V <sub>O</sub> = -4 V	SN65ALS176			-250	mA
		V <sub>O</sub> = -6 V	SN75ALS176			-250	
		V <sub>O</sub> = 0				-150	
		V <sub>O</sub> = V <sub>CC</sub>				250	
		V <sub>O</sub> = 8 V				250	
I <sub>CC</sub>	Supply current	No load	Outputs enabled		23	30	mA
			Outputs disabled		19	26	

- (1) The power-off measurement in TIA/EIA-422-B applies to disabled outputs only and is not applied to combined inputs and outputs.
- (2) All typical values are at V<sub>CC</sub> = 5 V and T<sub>A</sub> = 25°C.
- (3) The minimum V<sub>OD2</sub> with a 100-Ω load is either 1/2 V<sub>OD1</sub> or 2 V, whichever is greater.
- (4) Δ|V<sub>OD</sub>| and Δ|V<sub>Oc</sub>| are the changes in magnitude of VOD and VOC, respectively, that occur when the input is changed from one logic state to the other.
- (5) Duration of the short circuit should not exceed one second for this test.
- (6) This applies for power on and power off. Refer to TIA/EIA-485-A for exact conditions. The TIA/EIA-422-B limit does not apply for a combined driver and receiver terminal.

## 5.5 Switching Characteristics - Driver

### SN65ALS176

over recommended ranges of supply voltage and operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS			MIN	TYP <sup>(1)</sup>	MAX	UNIT
t <sub>d(OD)</sub>	Differential output delay time	R <sub>L</sub> = 54 Ω	C <sub>L</sub> = 50 pF,	See <a href="#">图 6-3</a>			15	ns
t <sub>sk(p)</sub>	Pulse skew <sup>(2)</sup>	R <sub>L</sub> = 54 Ω	C <sub>L</sub> = 50 pF,	See <a href="#">图 6-3</a>		0	2	ns
t <sub>sk(lim)</sub>	Pulse skew <sup>(3)</sup>	R <sub>L</sub> = 54 Ω	C <sub>L</sub> = 50 pF,	See <a href="#">图 6-3</a>			15	ns
t <sub>t(OD)</sub>	Differential output transition time	R <sub>L</sub> = 54 Ω	C <sub>L</sub> = 50 pF,	See <a href="#">图 6-3</a>		8		ns
t <sub>PZH</sub>	Output enable time to high level	R <sub>L</sub> = 110 Ω	C <sub>L</sub> = 50 pF,	See <a href="#">图 6-4</a>			80	ns
t <sub>PZL</sub>	Output enable time to low level	R <sub>L</sub> = 110 Ω	C <sub>L</sub> = 50 pF,	See <a href="#">图 6-5</a>			30	ns
t <sub>PHZ</sub>	Output disable time from high level	R <sub>L</sub> = 110 Ω	C <sub>L</sub> = 50 pF,	See <a href="#">图 6-4</a>			50	ns
t <sub>PLZ</sub>	Output disable time from low level	R <sub>L</sub> = 110 Ω	C <sub>L</sub> = 50 pF,	See <a href="#">图 6-5</a>			30	ns

- (1) All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C.

- (2) Pulse skew is defined as the  $|t_{PLH} - t_{PHL}|$  of each channel of the same device.
- (3) Skew limit is the maximum difference in propagation delay times between any two channels of any two devices.

## 5.6 Switching Characteristics - Driver

### SN75ALS176, SN75ALS176A, SN75ALS176B

over recommended ranges of supply voltage and operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS			MIN	TYP <sup>(1)</sup>	MAX	UNIT	
$t_{d(OD)}$	Differential output delay time	'ALS176	$R_L = 54 \Omega$	$C_L = 50 \text{ pF}$	See <a href="#">图 6-3</a>	3	8	13	ns
		'ALS176A				4	7	11.5	
		'ALS176B				5	8	10	
$t_{sk(p)}$	Pulse skew <sup>(2)</sup>		$R_L = 54 \Omega$	$C_L = 50 \text{ pF}$	See <a href="#">图 6-3</a>		0	2	ns
$t_{sk(lim)}$	Pulse skew <sup>(3)</sup>	'ALS176	$R_L = 54 \Omega$	$C_L = 50 \text{ pF}$	See <a href="#">图 6-3</a>			10	ns
		'ALS176A						7.5	
		'ALS176B						5	
$t_{i(OD)}$	Differential output transition time		$R_L = 54 \Omega$	$C_L = 50 \text{ pF}$	See <a href="#">图 6-3</a>		8		ns
$t_{PZH}$	Output enable time to high level		$R_L = 110 \Omega$	$C_L = 50 \text{ pF}$	See <a href="#">图 6-4</a>		23	50	ns
$t_{PZL}$	Output enable time to low level		$R_L = 110 \Omega$	$C_L = 50 \text{ pF}$	See <a href="#">图 6-5</a>		14	20	ns
$t_{PHZ}$	Output disable time from high level		$R_L = 110 \Omega$	$C_L = 50 \text{ pF}$	See <a href="#">图 6-4</a>		20	35	ns
$t_{PLZ}$	Output disable time from low level		$R_L = 110 \Omega$	$C_L = 50 \text{ pF}$	See <a href="#">图 6-5</a>		8	17	ns

- (1) All typical values are at  $V_{CC} = 5 \text{ V}$ ,  $T_A = 25^\circ\text{C}$ .
- (2) Pulse skew is defined as the  $|t_{PLH} - t_{PHL}|$  of each channel of the same device.
- (3) Skew limit is the maximum difference in propagation delay times between any two channels of any two devices.

## 5.7 Symbol Equivalents

DATA-SHEET PARAMETER	TIA/EIA-422-B	TIA/EIA-485-A
$V_O$	$V_{oa}, V_{ob}$	$V_{oa}, V_{ob}$
$ V_{OD1} $	$V_o$	$V_o$
$ V_{OD2} $	$V_t(R_L = 100 \Omega)$	$V_t(R_L = 54 \Omega)$
$ V_{OD3} $	None	$V_t$ (test termination measurement 2)
$\Delta V_{OD} $	$  V_t  -  V_t  $	$  V_t  -  V_t  $
$V_{OC}$	$ V_{os} $	$ V_{os} $
$\Delta V_{OC} $	$ V_{os} - V_{os} $	$ V_{os} - V_{os} $
$I_{OS}$	$ I_{sa} ,  I_{sb} $	None
$I_O$	$ I_{xa} ,  I_{xb} $	$I_{ia}, I_{ib}$

## 5.8 Electrical Characteristics - Receiver

over recommended ranges of common-mode input voltage, supply voltage, and operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP <sup>(1)</sup>	MAX	UNIT
V <sub>IT+</sub>	Positive-going input threshold voltage	V <sub>O</sub> = 2.7 V,	I <sub>O</sub> = -0.4 mA			0.2	V
V <sub>IT-</sub>	Negative-going input threshold voltage	V <sub>O</sub> = 0.5 V,	I <sub>O</sub> = 8 mA	-0.2 <sup>(2)</sup>			V
V <sub>hys</sub>	Hysteresis voltage (V <sub>IT+</sub> - V <sub>IT-</sub> )				60		mV
V <sub>IK</sub>	Enable-input clamp voltage	I <sub>I</sub> = -18 mA				-1.5	V
V <sub>OH</sub>	High-level output voltage	V <sub>ID</sub> = 200 mV, See 图 6-6	I <sub>OH</sub> = -400 mA,	2.7			V
V <sub>OL</sub>	Low-level output voltage	V <sub>ID</sub> = -200 mV, See Figure 6	I <sub>OL</sub> = 8 mA,			0.45	V
I <sub>OZ</sub>	High-impedance-state output current	V <sub>O</sub> = 0.4 V to 2.4 V				±20	μA
V <sub>I</sub>	Line input current	Other input = 0 V <sup>(3)</sup>	V <sub>I</sub> = 12 V			1	mA
			V <sub>I</sub> = -7 V			-0.8	
I <sub>IH</sub>	High-level-enable input current	V <sub>IH</sub> = 2.7 V				20	μA
I <sub>IL</sub>	Low-level-enable input current	V <sub>IL</sub> = 0.4 V				-100	μA
r <sub>I</sub>	Input resistance			12	20		kΩ
I <sub>OS</sub>	Short-circuit output current	V <sub>ID</sub> = 200 mV,	V <sub>O</sub> = 0	-15		-85	mA
I <sub>CC</sub>	Supply current	No load	Outputs enabled		23	30	mA
			Outputs disabled		19	26	

(1) All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C.

(2) The algebraic convention, in which the less positive (more negative) limit is designated minimum, is used in this data sheet for common-mode input voltage and threshold voltage levels only.

(3) This applies for power on and power off. Refer to TIA/EIA-485-A for exact conditions.

## 5.9 Switching Characteristics - Receiver

### SN65ALS176

over recommended ranges of supply voltage and operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP <sup>(1)</sup>	MAX	UNIT
t <sub>pd</sub>	Propagation time	V <sub>ID</sub> = -1.5 V to 1.5 V, See 图 6-7	C <sub>L</sub> = 15 pF,			25	ns
t <sub>sk(p)</sub>	Pulse skew <sup>(2)</sup>	V <sub>ID</sub> = -1.5 V to 1.5 V, See 图 6-7	C <sub>L</sub> = 15 pF,		0	2	ns
t <sub>sk(lim)</sub>	Pulse skew <sup>(3)</sup>	R <sub>L</sub> = 54 Ω See 图 6-3	C <sub>L</sub> = 50 pF,			15	ns
t <sub>PZH</sub>	Output enable time to high level	C <sub>L</sub> = 15 pF,	See 图 6-8		11	18	ns
t <sub>PZL</sub>	Output enable time to low level	C <sub>L</sub> = 15 pF,	See 图 6-8		11	18	ns
t <sub>PHZ</sub>	Output disable time from high level	C <sub>L</sub> = 15 pF,	See 图 6-8			50	ns
t <sub>PLZ</sub>	Output disable time from low level	C <sub>L</sub> = 15 pF,	See 图 6-8			30	ns

(1) All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C.

(2) Pulse skew is defined as the |t<sub>PLH</sub> - t<sub>PHL</sub>| of each channel of the same device.

(3) Skew limit is the maximum difference in propagation delay times between any two channels of any two devices.

## 5.10 Switching Characteristics - Receiver

### SN75ALS176, SN75ALS176A, SN75ALS176B

over recommended ranges of supply voltage and operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP <sup>(1)</sup>	MAX	UNIT	
t <sub>pd</sub>	Propagation time	'ALS176	V <sub>ID</sub> = -1.5 V to 1.5 V, See <a href="#">图 6-7</a>	C <sub>L</sub> = 15 pF,	9	14	19	ns
		'ALS176A			10.5	14	18	
		'ALS176B			11.5	13	16.5	
t <sub>sk(p)</sub>	Pulse skew <sup>(2)</sup>		V <sub>ID</sub> = -1.5 V to 1.5 V, See <a href="#">图 6-7</a>	C <sub>L</sub> = 15 pF,		0	2	ns
t <sub>sk(lim)</sub>	Pulse skew <sup>(3)</sup>	'ALS176	R <sub>L</sub> = 54 Ω See <a href="#">图 6-3</a>	C <sub>L</sub> = 50 pF,			10	ns
		'ALS176A					7.5	
		'ALS176B					5	
t <sub>PZH</sub>	Output enable time to high level		C <sub>L</sub> = 15 pF,	See <a href="#">图 6-8</a>		7	14	ns
t <sub>PZL</sub>	Output enable time to low level		C <sub>L</sub> = 15 pF,	See <a href="#">图 6-8</a>		20	35	ns
t <sub>PHZ</sub>	Output disable time from high level		C <sub>L</sub> = 15 pF,	See <a href="#">图 6-8</a>		20	35	ns
t <sub>PLZ</sub>	Output disable time from low level		C <sub>L</sub> = 15 pF,	See <a href="#">图 6-8</a>		8	17	ns

(1) All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C.

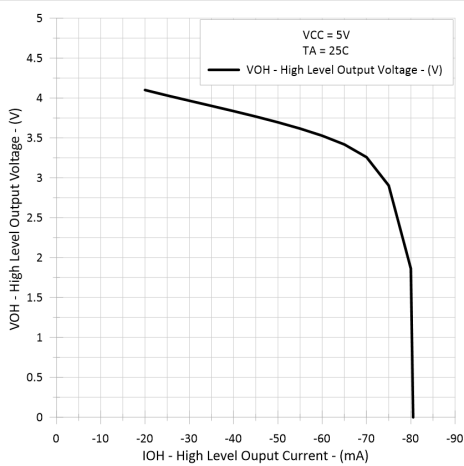
(2) Pulse skew is defined as the |t<sub>PLH</sub> - t<sub>PHL</sub>| of each channel of the same device.

(3) Skew limit is the maximum difference in propagation delay times between any two channels of any two devices.

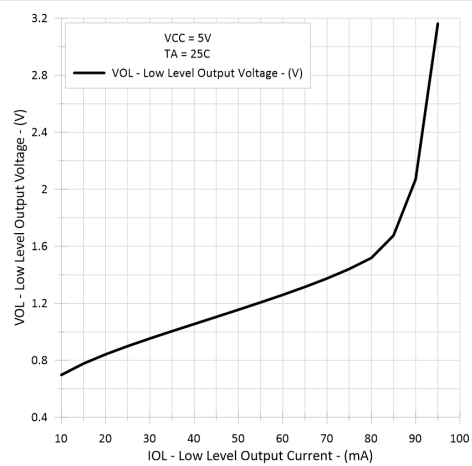


## 5.11 Typical Characteristics

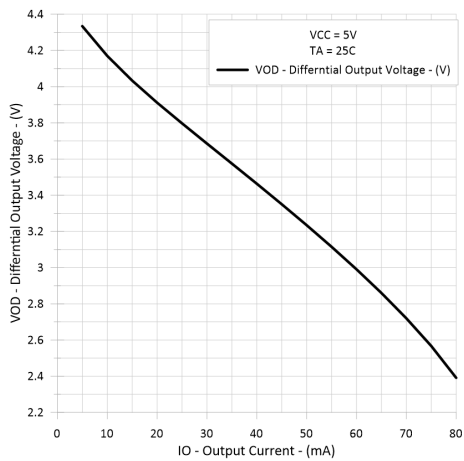
Operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied.



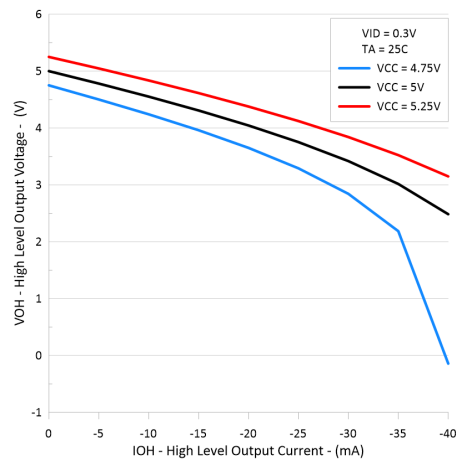
**图 5-1. Driver High-Level Output Voltage vs High-Level Output Current**



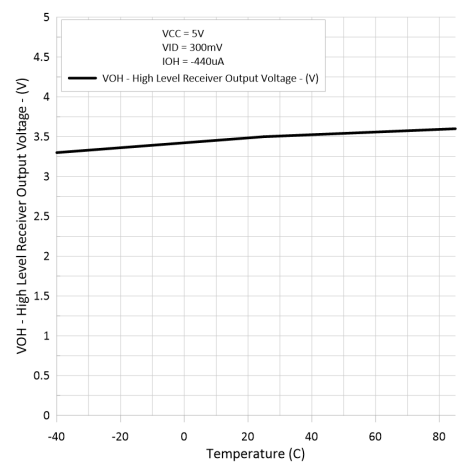
**图 5-2. Driver Low-Level Output Voltage vs Low-Level Output Current**



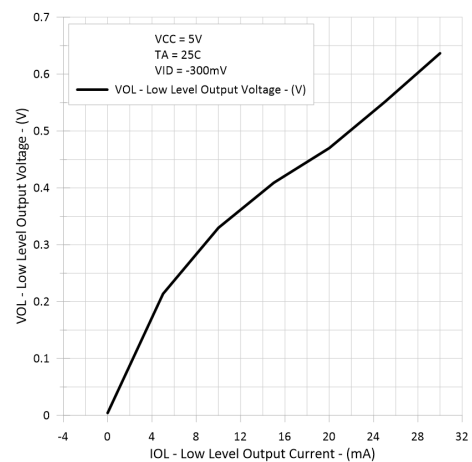
**图 5-3. Driver Differential Output Voltage vs Output Current**



**图 5-4. Receiver High-Level Output Voltage vs High-Level Output Current**



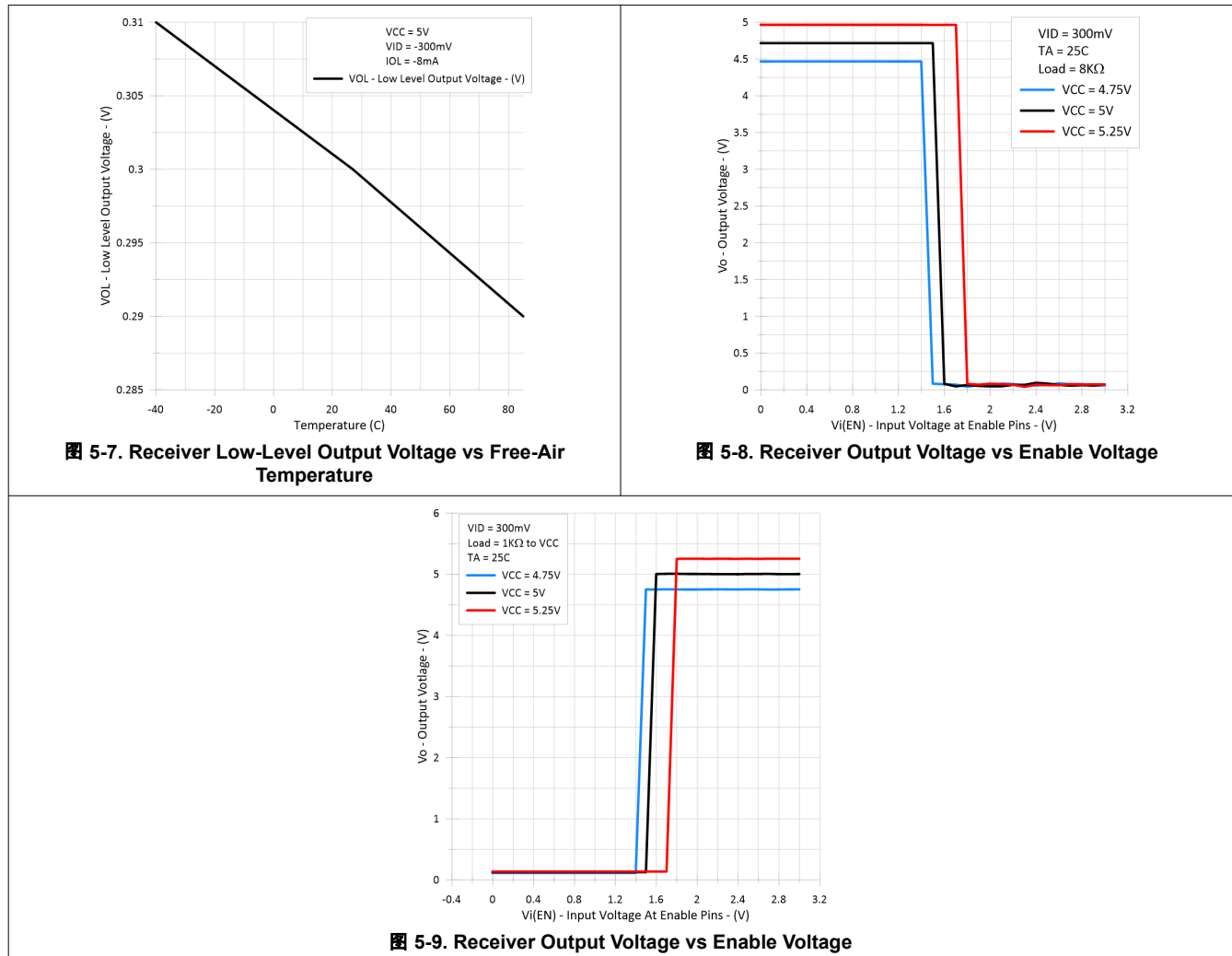
**图 5-5. Receiver High-Level Output Voltage vs Free-Air Temperature**



**图 5-6. Receiver Low-Level Output Voltage vs Low-Level Output Current**

## 5.11 Typical Characteristics (continued)

Operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied.



## 6 Parameter Measurement Information

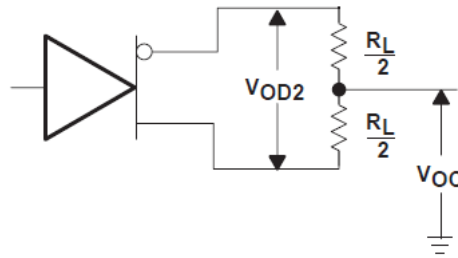


图 6-1. Driver  $V_{OD2}$  and  $V_{OC}$

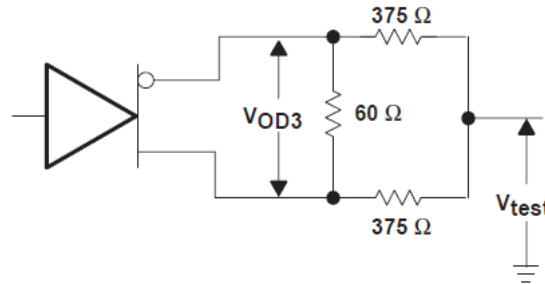
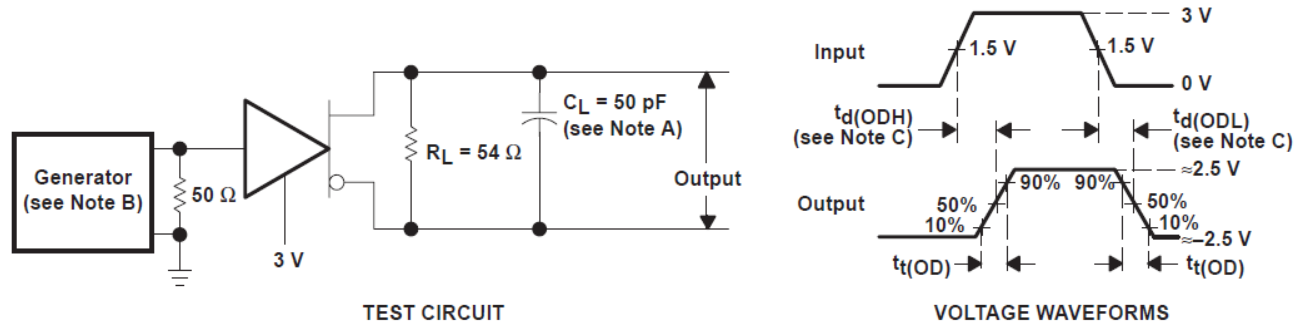
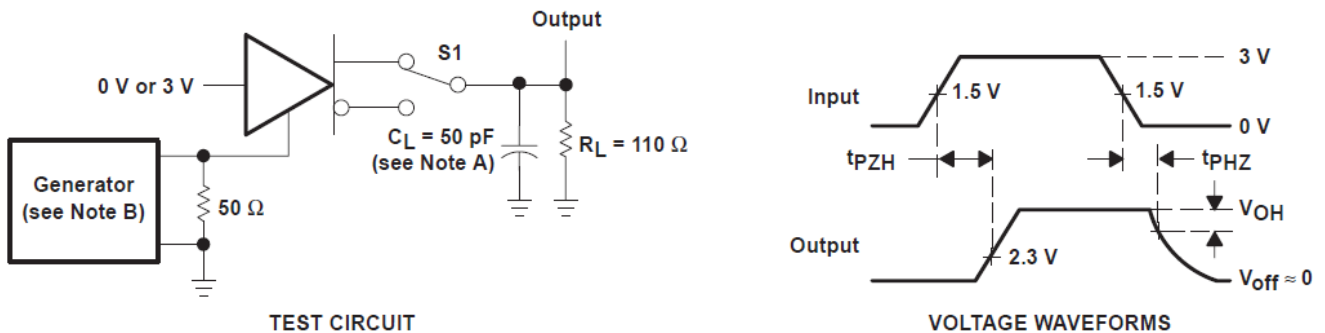


图 6-2. Driver  $V_{OD3}$



- A.  $C_L$  includes probe and jig capacitance.  
 B. The input pulse is supplied by a generator having the following characteristics:  $PRR \leq 1$  MHz, 50% duty cycle,  $t_r \leq 6$  ns,  $t_f \leq 6$  ns,  $Z_O = 50 \Omega$ .

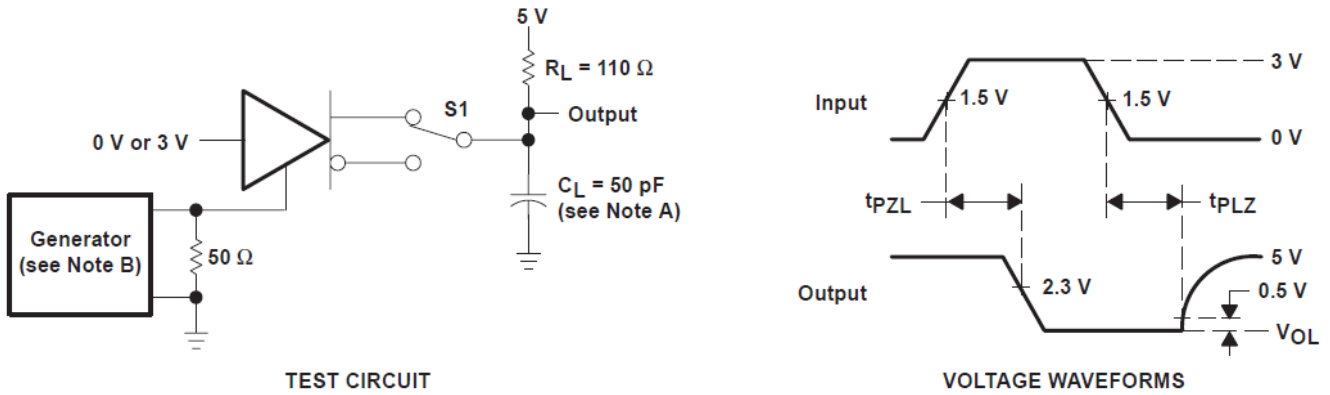
图 6-3. Driver Test Circuit and Voltage Waveforms



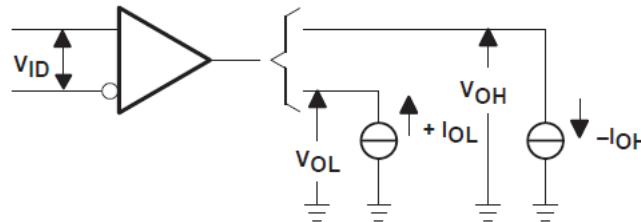
- A.  $C_L$  includes probe and jig capacitance.

- B. The input pulse is supplied by a generator having the following characteristics: PRR  $\leq$  1 MHz, 50% duty cycle,  $t_r \leq$  6 ns,  $t_f \leq$  6 ns,  $Z_O = 50 \Omega$ .

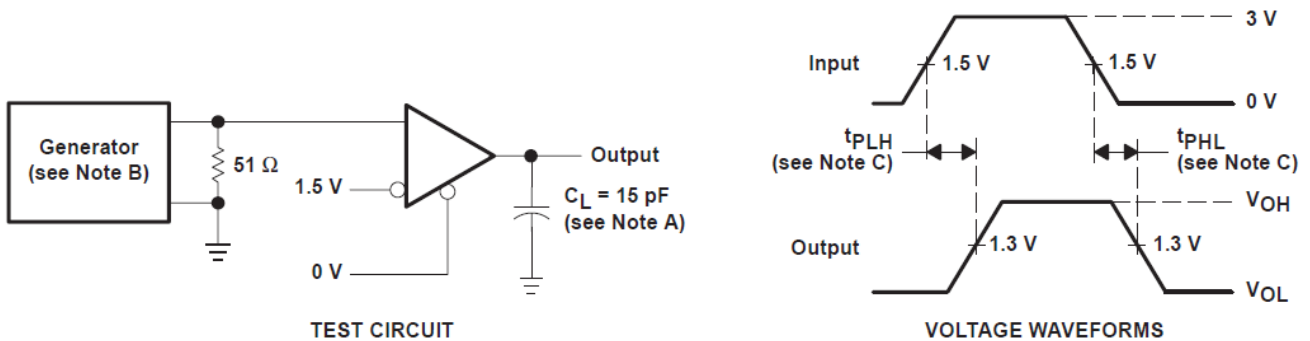
**图 6-4. Driver Test Circuit and Voltage Waveforms**



**图 6-5. Driver Test Circuit and Voltage Waveforms**

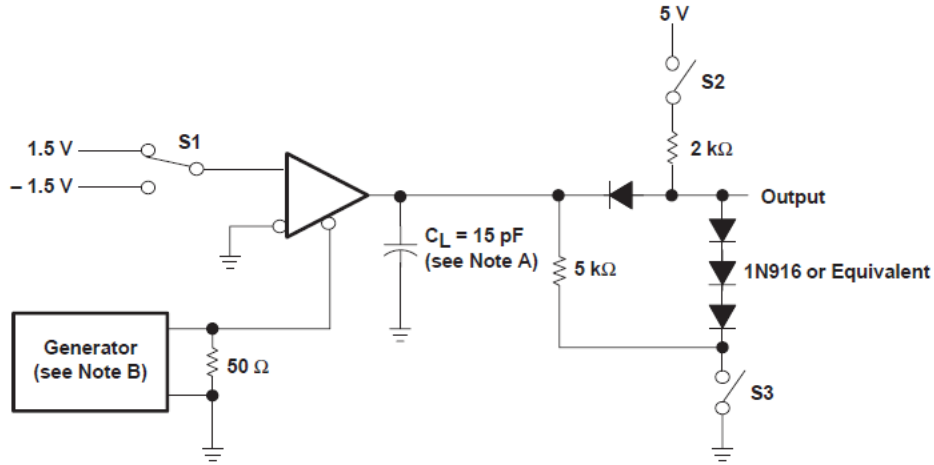


**图 6-6. Receiver VOH and VOL Test Circuit**

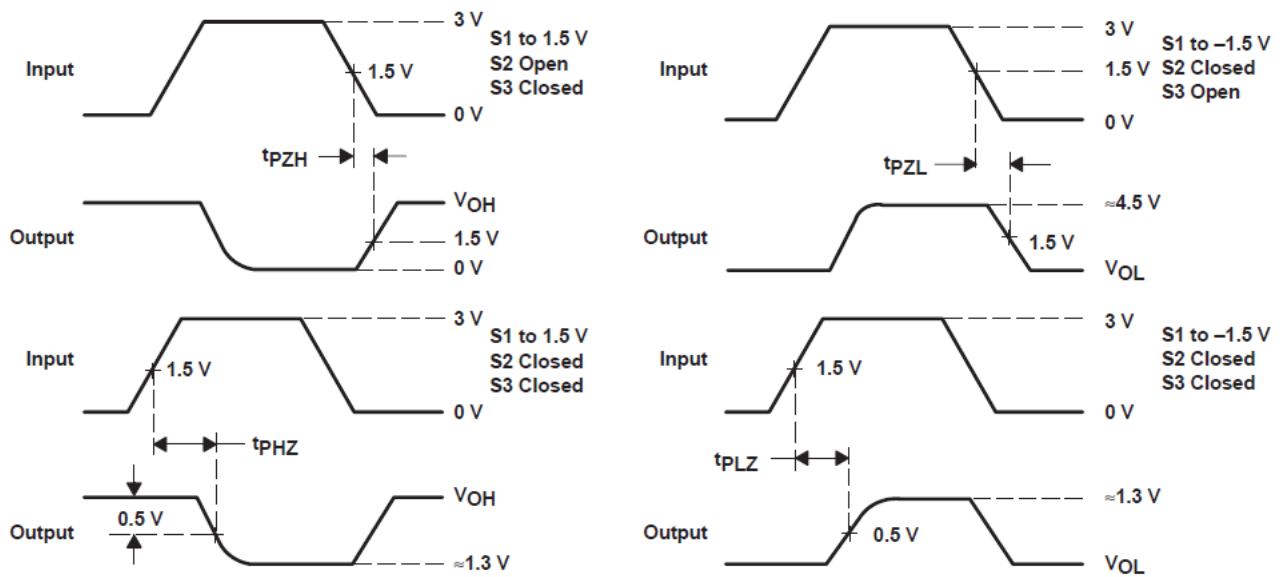


- A.  $C_L$  includes probe and jig capacitance.  
 B. The input pulse is supplied by a generator having the following characteristics: PRR  $\leq$  1 MHz, 50% duty cycle,  $t_r \leq$  6 ns,  $t_f \leq$  6 ns,  $Z_O = 50 \Omega$ .  
 C.  $t_{pd} = t_{PLH}$  or  $t_{PHL}$ .

**图 6-7. Receiver Test Circuit and Voltage Waveforms**



TEST CIRCUIT



VOLTAGE WAVEFORMS

- A.  $C_L$  includes probe and jig capacitance.  
 B. The input pulse is supplied by a generator having the following characteristics:  $PRR \leq 1$  MHz, 50% duty cycle,  $t_r \leq 6$  ns,  $t_f \leq 6$  ns,  $Z_O = 50 \Omega$ .

图 6-8. Receiver Test Circuit and Voltage Waveforms

## 7 Detailed Description

### 7.1 Functional Block Diagram

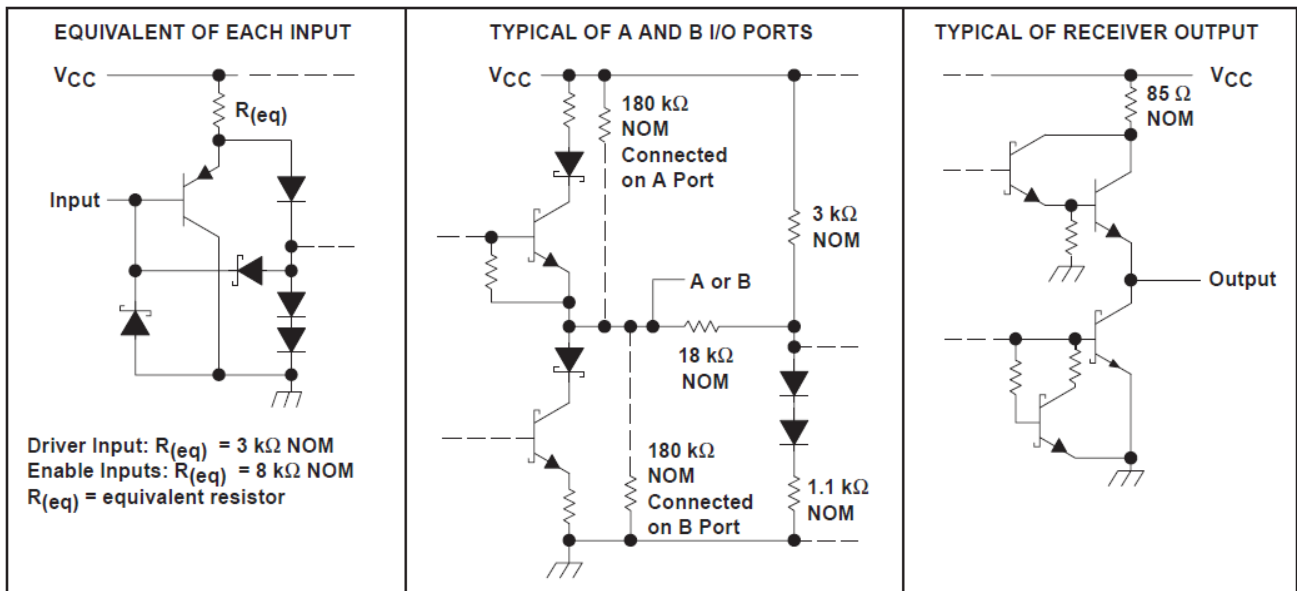


图 7-1. Schematic of Inputs and Outputs

### 7.2 Device Functional Modes

#### Function Tables

表 7-1. Driver<sup>(1)</sup>

INPUT D	ENABLE DE	OUTPUTS	
		A	B
H	H	H	L
L	H	L	H
X	L	Z	Z

(1) H = high level, L = low level, X = irrelevant, Z = high impedance

表 7-2. Receiver<sup>(1)</sup>

DIFFERENTIAL INPUTS A-B	ENABLE RE	OUTPUT R
$V_{ID} \geq 0.2\text{ V}$	L	H
$-0.2\text{ V} < V_{ID} < 0.2\text{ V}$	L	?
$V_{ID} \leq -0.2\text{ V}$	L	L
X	H	Z
Inputs open	L	H

(1) H = high level, L = low level, X = irrelevant, Z = high impedance

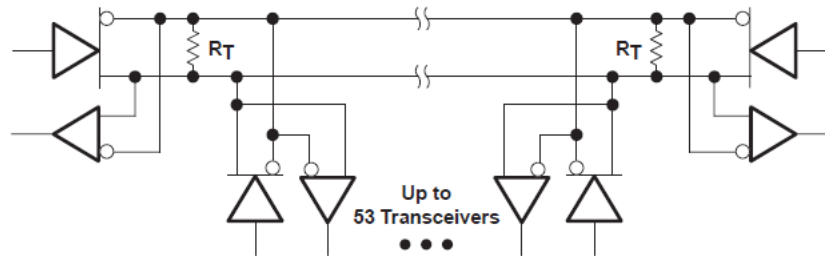
## 8 Application and Implementation

### 备注

以下应用部分中的信息不属于 TI 元件规格，TI 不担保其准确性和完整性。TI 的客户负责确定元件是否适合其用途，以及验证和测试其设计实现以确认系统功能。

### 8.1 Application Information

### 8.2 Typical Application



- A. The line should terminate at both ends in its characteristic impedance ( $R_T = Z_0$ ). Stub lengths off the main line should be kept as short as possible.

图 8-1. Typical Application Circuit

## 9 Device and Documentation Support

TI offers an extensive line of development tools. Tools and software to evaluate the performance of the device, generate code, and develop solutions are listed below.

### 9.1 Documentation Support

#### 9.1.1 Related Documentation

### 9.2 接收文档更新通知

要接收文档更新通知，请导航至 [ti.com](https://www.ti.com) 上的器件产品文件夹。点击 [订阅更新](#) 进行注册，即可每周接收产品信息更改摘要。有关更改的详细信息，请查看任何已修订文档中包含的修订历史记录。

### 9.3 支持资源

TI E2E™ [支持论坛](#) 是工程师的重要参考资料，可直接从专家获得快速、经过验证的解答和设计帮助。搜索现有解答或提出自己的问题可获得所需的快速设计帮助。

链接的内容由各个贡献者“按原样”提供。这些内容并不构成 TI 技术规范，并且不一定反映 TI 的观点；请参阅 TI 的《[使用条款](#)》。

### 9.4 Trademarks

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### 9.5 静电放电警告



静电放电 (ESD) 会损坏这个集成电路。德州仪器 (TI) 建议通过适当的预防措施处理所有集成电路。如果不遵守正确的处理和安装程序，可能会损坏集成电路。

ESD 的损坏小至导致微小的性能降级，大至整个器件故障。精密的集成电路可能更容易受到损坏，这是因为非常细微的参数更改都可能会导致器件与其发布的规格不相符。

### 9.6 术语表

#### TI 术语表

本术语表列出并解释了术语、首字母缩略词和定义。

## 10 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



**PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
SN65ALS176D	ACTIVE	SOIC	D	8	75	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	65A176	<a href="#">Samples</a>
SN65ALS176DR	ACTIVE	SOIC	D	8	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	65A176	<a href="#">Samples</a>
SN75ALS176AD	ACTIVE	SOIC	D	8	75	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	7A176A	<a href="#">Samples</a>
SN75ALS176ADR	ACTIVE	SOIC	D	8	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	7A176A	<a href="#">Samples</a>
SN75ALS176ADRG4	ACTIVE	SOIC	D	8	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	7A176A	<a href="#">Samples</a>
SN75ALS176AP	ACTIVE	PDIP	P	8	50	RoHS & Green	NIPDAU	N / A for Pkg Type	0 to 70	75ALS176A	<a href="#">Samples</a>
SN75ALS176BD	ACTIVE	SOIC	D	8	75	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	7A176B	<a href="#">Samples</a>
SN75ALS176BDR	ACTIVE	SOIC	D	8	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	7A176B	<a href="#">Samples</a>
SN75ALS176BP	ACTIVE	PDIP	P	8	50	RoHS & Green	NIPDAU	N / A for Pkg Type	0 to 70	75ALS176B	<a href="#">Samples</a>
SN75ALS176D	ACTIVE	SOIC	D	8	75	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	75A176	<a href="#">Samples</a>
SN75ALS176DR	ACTIVE	SOIC	D	8	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	75A176	<a href="#">Samples</a>
SN75ALS176P	ACTIVE	PDIP	P	8	50	RoHS & Green	NIPDAU	N / A for Pkg Type	0 to 70	75ALS176	<a href="#">Samples</a>
SN75ALS176PE4	ACTIVE	PDIP	P	8	50	RoHS & Green	NIPDAU	N / A for Pkg Type	0 to 70	75ALS176	<a href="#">Samples</a>

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSELETE:** TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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**TAPE AND REEL INFORMATION**

**QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE**


\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN65ALS176DR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
SN75ALS176ADR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
SN75ALS176BDR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
SN75ALS176DR	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1

**TAPE AND REEL BOX DIMENSIONS**


\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN65ALS176DR	SOIC	D	8	2500	340.5	336.1	25.0
SN75ALS176ADR	SOIC	D	8	2500	340.5	336.1	25.0
SN75ALS176BDR	SOIC	D	8	2500	340.5	336.1	25.0
SN75ALS176DR	SOIC	D	8	2500	340.5	336.1	25.0

**TUBE**


\*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (μm)	B (mm)
SN65ALS176D	D	SOIC	8	75	507	8	3940	4.32
SN75ALS176AD	D	SOIC	8	75	507	8	3940	4.32
SN75ALS176AP	P	PDIP	8	50	506	13.97	11230	4.32
SN75ALS176BD	D	SOIC	8	75	507	8	3940	4.32
SN75ALS176BP	P	PDIP	8	50	506	13.97	11230	4.32
SN75ALS176D	D	SOIC	8	75	507	8	3940	4.32
SN75ALS176P	P	PDIP	8	50	506	13.97	11230	4.32
SN75ALS176PE4	P	PDIP	8	50	506	13.97	11230	4.32



D0008A

# PACKAGE OUTLINE

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



4214825/C 02/2019

NOTES:

1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed  $.006$  [0.15] per side.
4. This dimension does not include interlead flash.
5. Reference JEDEC registration MS-012, variation AA.

# EXAMPLE BOARD LAYOUT

D0008A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE:8X



SOLDER MASK DETAILS

4214825/C 02/2019

NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

# EXAMPLE STENCIL DESIGN

D0008A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



SOLDER PASTE EXAMPLE  
BASED ON .005 INCH [0.125 MM] THICK STENCIL  
SCALE:8X

4214825/C 02/2019

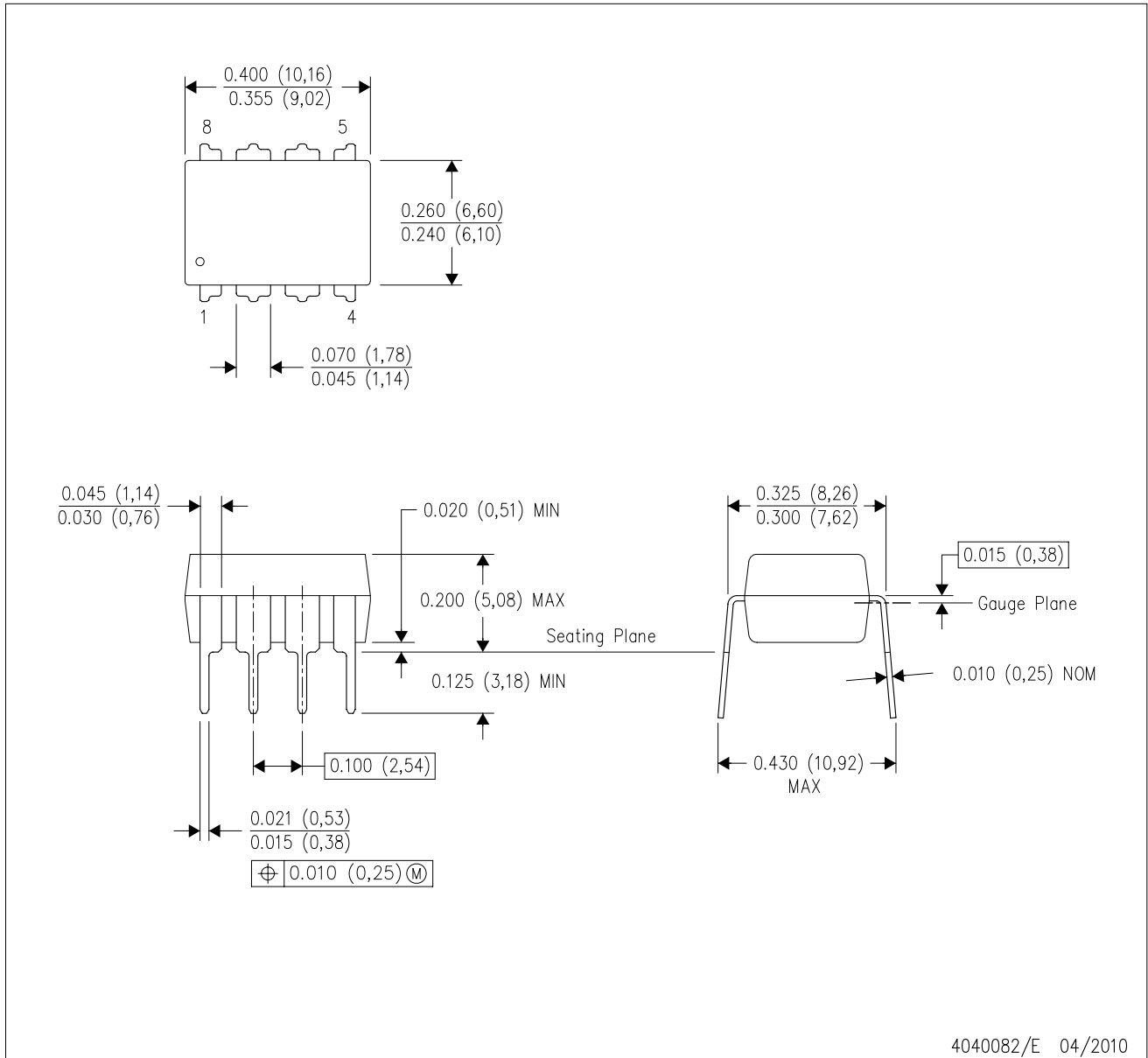
NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.



P (R-PDIP-T8)

PLASTIC DUAL-IN-LINE PACKAGE



- NOTES:
- A. All linear dimensions are in inches (millimeters).
  - B. This drawing is subject to change without notice.
  - C. Falls within JEDEC MS-001 variation BA.

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